

**Product data sheet** 

#### **1. General description**

Planar passivated Silicon Controlled Rectifier (SCR) in a TO220 plastic package intended for use in applications requiring good bidirectional blocking voltage and high current surge capability with high thermal cycling performance and high junction temperature capability ( $T_{i(max)} = 150$  °C).

#### 2. Features and benefits

- High junction operating temperature capability (T<sub>i(max)</sub> = 150 °C)
- · Good bidirectional blocking voltage capability
- · High current surge capability
- High thermal cycling performance
- · Planar passivated for voltage ruggedness and reliability

### 3. Applications

- · Capacitive Discharge Ignition (CDI)
- Crowbar protection
- Inrush protection
- Motor control
- Voltage regulation
- High junction operating temperature capability (T<sub>j(max)</sub> = 150 °C)

#### 4. Quick reference data

Table 1. Quic	k reference data							
Symbol	Parameter	Conditions	Values	Unit				
Absolute m	Absolute maximum rating							
V <sub>RRM</sub>	repetitive peak reverse voltage		650	V				
I <sub>T(RMS)</sub>	RMS on-state current	half sine wave; T <sub>mb</sub> ≤ 134 °C; <u>Fig. 1; Fig. 2; Fig. 3</u>	12	A				
I <sub>TSM</sub>	non-repetitive peak on- state current	half sine wave; T <sub>j(init)</sub> = 25 °C; t <sub>p</sub> = 10 ms; <u>Fig. 4; Fig. 5</u>	120	A				
		half sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 8.3 ms	132	А				
T <sub>j</sub>	junction temperature		150	°C				

SCR

Symbol	Parameter	Conditions		Min	Тур	Max	Unit	
Static cha	Static characteristics							
I <sub>GT</sub>	gate trigger current	$V_{D}$ = 12 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 25 °C; <u>Fig. 7</u>		1.5	-	5	mA	
I <sub>H</sub>	holding current	V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; <u>Fig. 9</u>		-	-	20	mA	
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 12 A; T <sub>j</sub> = 25 °C; <u>Fig. 10</u>		-	1.15	1.5	V	
Dynamic	Dynamic characteristics							
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 436 V; T <sub>j</sub> = 150 °C; R <sub>GK</sub> = 100 $\Omega$ ; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform;		500	1000	-	V/µs	

# 5. Pinning information

Table 2. P	Table 2. Pinning information							
Pin	Symbol	Description	Simplified outline	Graphic symbol				
1	К	cathode	mb					
2	А	anode	204	A H K G				
3	G	gate		sym037				
mb	A	mounting base; connected to anode						

# 6. Ordering information

Table 3. Ordering information								
Type number	Package name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date		
BT151-650LTN	TO220	BT151-650LTNQ	Tube	50	SOT78	8-Jun-2013		

#### 7. Marking

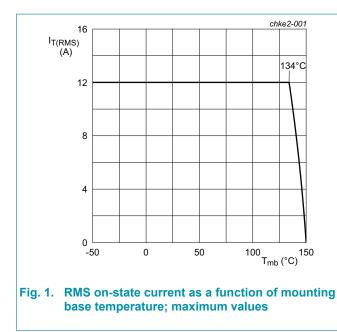
Table 4. Marking codes	
Type number	Marking codes
BT151-650LTN	BT151-650LTN

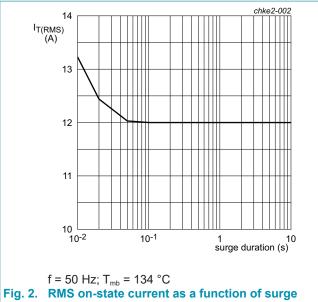
### 8. Limiting values

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
$V_{\text{DRM}}$	repetitive peak off-state voltage		650	V
V <sub>RRM</sub>	repetitive peak reverse voltage		650	V
I <sub>T(AV)</sub>	average on-state current	half sine wave; $T_{mb} \le 134 \text{ °C}$ ;	7.5	A
I <sub>T(RMS)</sub>	RMS on-state current	half sine wave; T <sub>mb</sub> ≤ 134 °C; <u>Fig. 1; Fig. 2; Fig. 3</u>	12	A
I <sub>TSM</sub>	non-repetitive peak on- state current	half sine wave; T <sub>j(init)</sub> = 25 °C; t <sub>p</sub> = 10 ms; <u>Fig. 4; Fig. 5</u>	120	A
		half sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 8.3 ms	132	A
l <sup>2</sup> t	l <sup>2</sup> t for fusing	t <sub>p</sub> = 10ms; sine wave	72	A <sup>2</sup> s
dl⊤/dt	rate of rise of on-state current	I <sub>G</sub> = 10mA	50	A/µs
I <sub>GM</sub>	peak gate current		2	A
V <sub>RGM</sub>	peak reverse gate voltage		18	V
P <sub>GM</sub>	peak gate power		5	W
P <sub>G(AV)</sub>	average gate power	over any 20 ms period	0.5	W
T <sub>stg</sub>	storage temperature		-40 to 150	°C
Tj	junction temperature		150	°C



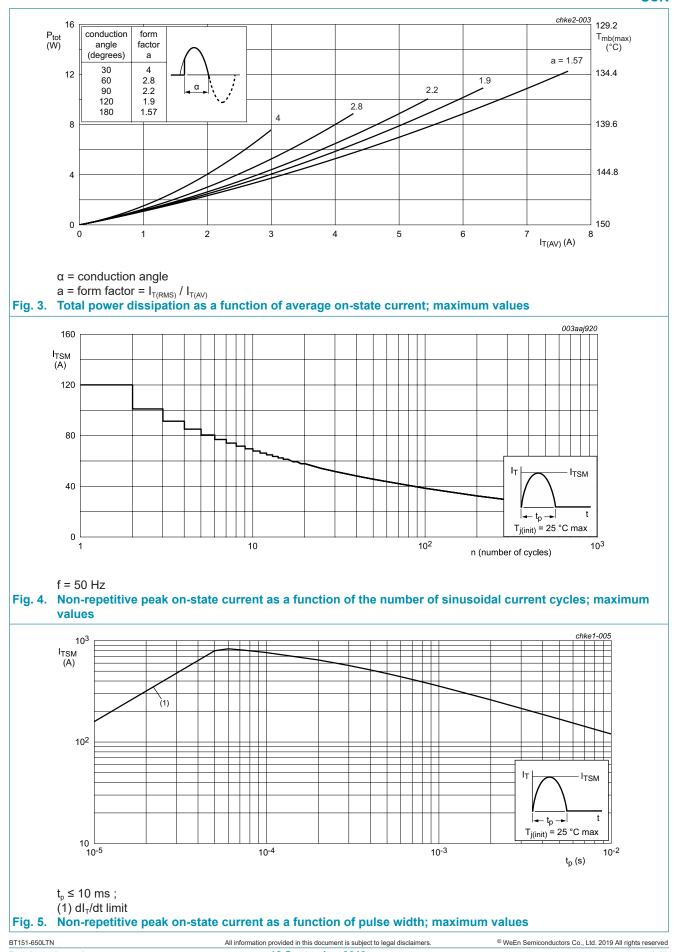


duration; maximum values

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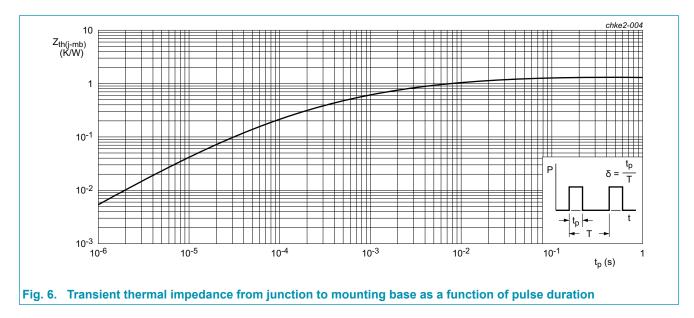
## **BT151-650LTN**

SCR



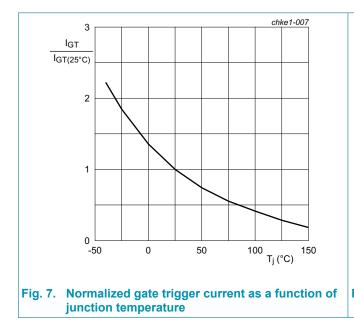
### 9. Thermal characteristics

able 6. Th Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	<u>Fig. 6</u>	-	-	1.3	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient free air	in free air	-	60	-	K/W



### **10. Characteristics**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
I <sub>GT</sub>	gate trigger current	$V_{D}$ = 12 V; $I_{T}$ = 0.1 A; $T_{j}$ = 25 °C; <u>Fig. 7</u>	1.5	-	5	mA
I <sub>L</sub>	latching current	V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 25 °C; <u>Fig. 8</u>	-	-	40	mA
I <sub>H</sub>	holding current	V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; <u>Fig. 9</u>	-	-	20	mA
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 12 A; T <sub>j</sub> = 25 °C; <u>Fig. 10</u>	-	1.15	1.5	V
V <sub>gt</sub>	gate trigger voltage	$V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T}_{j} = 25 \text{ °C};$ Fig. 11	-	0.65	1	V
		V <sub>D</sub> = 400 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 150 °C	0.2	0.4	-	V
I <sub>D</sub>	off-state current	V <sub>D</sub> = 650 V; T <sub>j</sub> = 150 °C	-	-	1	mA
I <sub>R</sub>	reverse current	V <sub>D</sub> = 650 V; T <sub>j</sub> = 150 °C	-	-	1	mA
Dynamic o	characteristics					
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 436 V; T <sub>j</sub> = 150 °C; R <sub>GK</sub> = 100 $\Omega$ ; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform;	500	1000	-	V/µs
		$V_{DM}$ = 436 V; T <sub>j</sub> = 150 °C; ( $V_{DM}$ = 67% of $V_{DRM}$ ); exponential waveform; gate open circuit	50	-	-	V/µs
t <sub>gt</sub>	gate-controlled turn-on time	$I_{TM}$ = 12 A; V <sub>D</sub> = 650 V; I <sub>G</sub> = 100 mA; (dI <sub>G</sub> /dt) <sub>M</sub> = 5 A/µs; T <sub>j</sub> = 25 °C		2	-	μs
t <sub>q</sub>	commutated turn-off time			70	-	μs



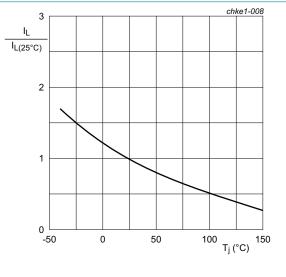
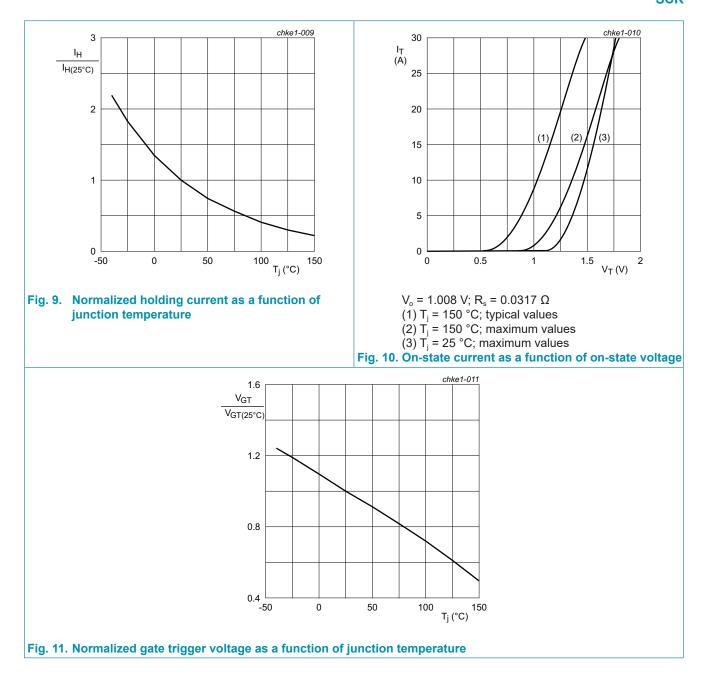


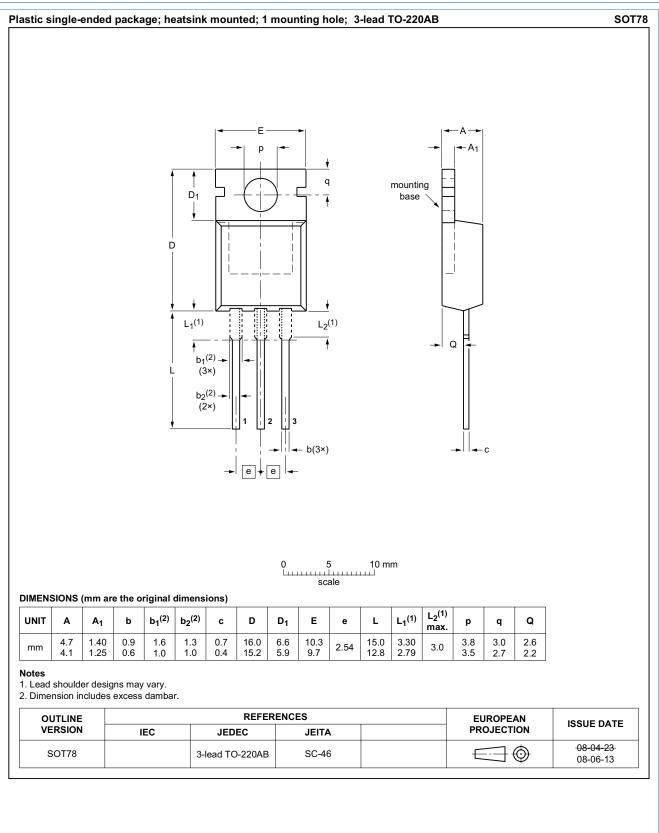
Fig. 8. Normalized latching current as a function of junction temperature

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# BT151-650LTN



#### **11. Package outline**



## 12. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions".
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